

## Features

- High blocking voltage with low On-resistance
- High speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Qrr)
- Halogen free, RoHS compliant

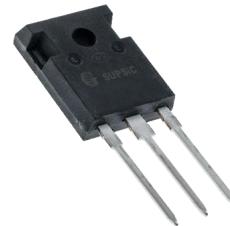
## Benefits

- Higher system efficiency
- Reduced cooling requirements
- Increased power density
- Increased system switching frequency

## Applications

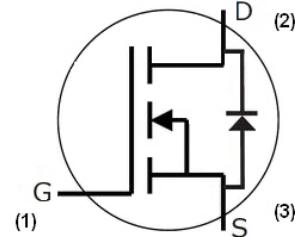
- Renewable energy
- EV battery chargers
- High voltage DC/DC converters
- Switch Mode Power Supplies

$V_{DS}$	1200 V
$I_D @ 25^\circ C$	32 A
$R_{DS(on)}$	75 mΩ



TO-247-3

## Package



Part Number	Package	Marking
GC3M0075120D	TO 247-3	GC3M0075120

## Maximum Ratings ( $T_c = 25^\circ C$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
$V_{DSmax}$	Drain - Source Voltage	1200	V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$	
$V_{GSmax}$	Gate - Source Voltage (dynamic)	-8/+19	V	AC ( $f > 1 \text{ Hz}$ )	Note: 1
$V_{GSop}$	Gate - Source Voltage (static)	-4/+15	V	Static	Note: 2
$I_D$	Continuous Drain Current	32	A	$V_{GS} = 15 \text{ V}, T_c = 25^\circ \text{C}$	Fig. 19
		23		$V_{GS} = 15 \text{ V}, T_c = 100^\circ \text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	80	A	Pulse width $t_p$ limited by $T_{jmax}$	Fig. 22
$P_D$	Power Dissipation	136	W	$T_c = 25^\circ \text{C}, T_j = 175^\circ \text{C}$	Fig. 20
$T_J, T_{stg}$	Operating Junction and Storage Temperature	-40 to +175	°C		
$T_L$	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	
$M_d$	Mounting Torque	1 8.8	Nm lbf-in	M3 or 6-32 screw	

Note (1): When using MOSFET Body Diode  $V_{GSmax} = -4\text{V}/+19\text{V}$

Note (2): MOSFET can also safely operate at 0/+15 V



**Electrical Characteristics** ( $T_c = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note		
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200			V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$			
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.8	2.5	3.6	V	$V_{DS} = V_{GS}, I_D = 5 \text{ mA}$	Fig. 11		
			2.2		V	$V_{DS} = V_{GS}, I_D = 5 \text{ mA}, T_J = 175^\circ\text{C}$			
$I_{DSS}$	Zero Gate Voltage Drain Current		1	100	$\mu\text{A}$	$V_{DS} = 1200 \text{ V}, V_{GS} = 0 \text{ V}$			
$I_{GSS}$	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$			
$R_{DS(on)}$	Drain-Source On-State Resistance		75	90	$\text{m}\Omega$	$V_{GS} = 15 \text{ V}, I_D = 20 \text{ A}$	Fig. 4, 5, 6		
			120			$V_{GS} = 15 \text{ V}, I_D = 20 \text{ A}, T_J = 175^\circ\text{C}$			
$g_{fs}$	Transconductance		12		S	$V_{DS} = 20 \text{ V}, I_{DS} = 20 \text{ A}$	Fig. 7		
			13			$V_{DS} = 20 \text{ V}, I_{DS} = 20 \text{ A}, T_J = 175^\circ\text{C}$			
$C_{iss}$	Input Capacitance		1390		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 1000 \text{ V}$ $f = 1 \text{ MHz}$ $V_{AC} = 25 \text{ mV}$	Fig. 17, 18		
$C_{oss}$	Output Capacitance		58						
$C_{rss}$	Reverse Transfer Capacitance		2						
$E_{oss}$	$C_{oss}$ Stored Energy		33		$\mu\text{J}$	$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 20 \text{ A},$ $R_{G(\text{ext})} = 0 \Omega, L = 157 \mu\text{H}, T_J = 150^\circ\text{C}$	Fig. 16		
$E_{ON}$	Turn-On Switching Energy (SiC Diode FWD)		564		$\mu\text{J}$				
$E_{OFF}$	Turn Off Switching Energy (SiC Diode FWD)		186						
$E_{ON}$	Turn-On Switching Energy (Body Diode FWD)		924		$\mu\text{J}$	$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 20 \text{ A},$ $R_{G(\text{ext})} = 0 \Omega, L = 157 \mu\text{H}, T_J = 150^\circ\text{C}$	Fig. 26, 29		
$E_{OFF}$	Turn Off Switching Energy (Body Diode FWD)		162						
$t_{d(on)}$	Turn-On Delay Time		56						
$t_r$	Rise Time		17		ns	$V_{DD} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_D = 20 \text{ A}, R_{G(\text{ext})} = 0 \Omega,$ Timing relative to $V_{DS}$ Inductive load	Fig. 27, 28		
$t_{d(off)}$	Turn-Off Delay Time		32						
$t_f$	Fall Time		13						
$R_{G(int)}$	Internal Gate Resistance		9.0		$\Omega$	$f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$			
$Q_{gs}$	Gate to Source Charge		17		nC	$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_D = 20 \text{ A}$ Per IEC60747-8-4 pg 21	Fig. 12		
$Q_{gd}$	Gate to Drain Charge		20						
$Q_g$	Total Gate Charge		54						

**Reverse Diode Characteristics** ( $T_c = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions		Note
$V_{SD}$	Diode Forward Voltage	4.5		V	$V_{GS} = -4 \text{ V}, I_{SD} = 10 \text{ A}$	$V_{GS} = -4 \text{ V}, I_{SD} = 10 \text{ A}, T_J = 175^\circ\text{C}$	Fig. 8, 9, 10
		4.0		V	$V_{GS} = -4 \text{ V}, I_{SD} = 10 \text{ A}, T_J = 175^\circ\text{C}$		
$I_S$	Continuous Diode Forward Current		26	A	$V_{GS} = -4 \text{ V}, T_J = 25^\circ\text{C}$		Note 1
$I_{S,pulse}$	Diode pulse Current	80		A	$V_{GS} = -4 \text{ V}$ , pulse width $t_p$ limited by $T_{jmax}$		Note 1
$t_{rr}$	Reverse Recover time	48		ns	$V_{GS} = -4 \text{ V}, I_{SD} = 20 \text{ A}, V_R = 800 \text{ V}$ $dif/dt = 2800 \text{ A}/\mu\text{s}, T_J = 150^\circ\text{C}$		Note 1
$Q_{rr}$	Reverse Recovery Charge	279		nC			
$I_{rrm}$	Peak Reverse Recovery Current	9		A			

**Thermal Characteristics**

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.97	1.1	$^\circ\text{C}/\text{W}$		
$R_{\theta JA}$	Thermal Resistance From Junction to Ambient		40			Fig. 21

## Typical Performance

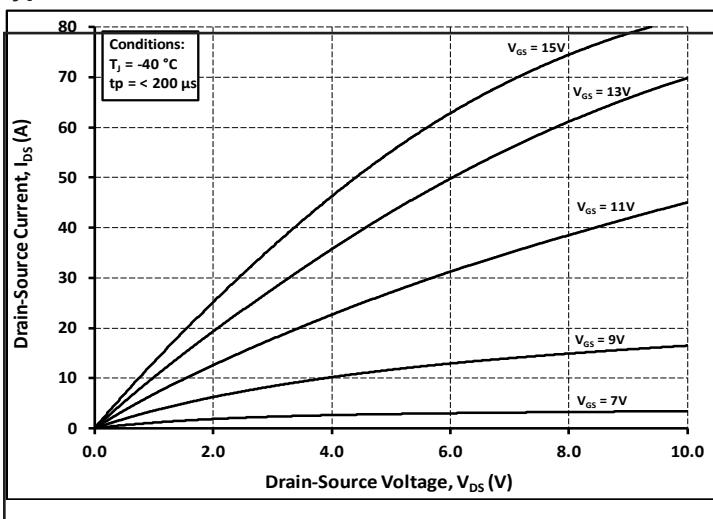


Figure 1. Output Characteristics  $T_J = -40 \text{ }^{\circ}\text{C}$

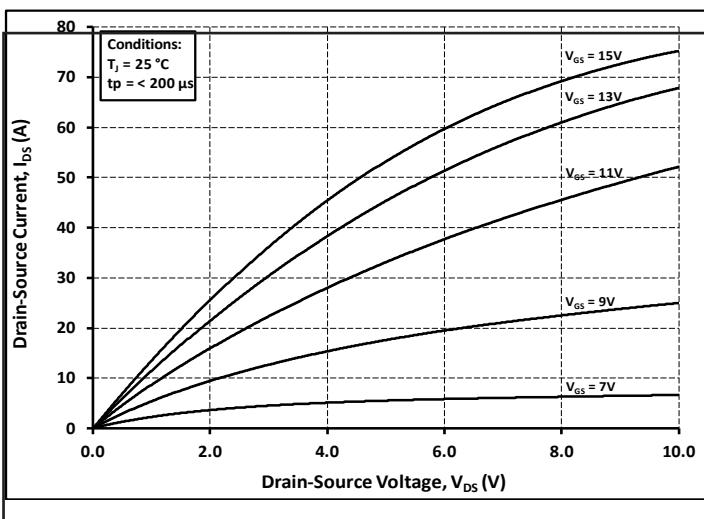


Figure 2. Output Characteristics  $T_J = 25 \text{ }^{\circ}\text{C}$

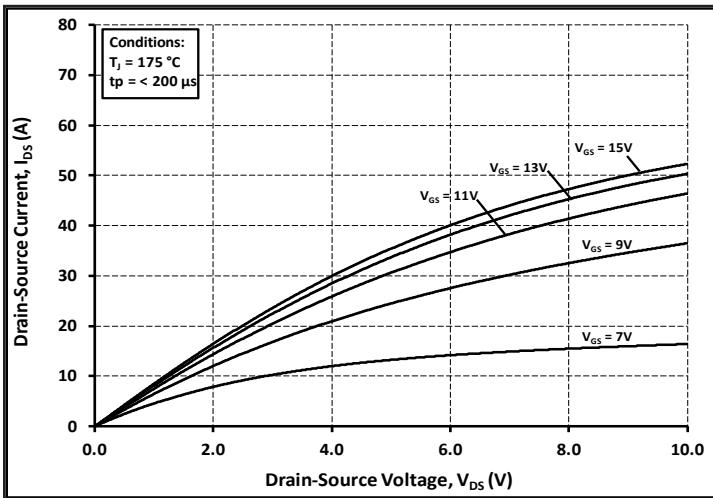


Figure 3. Output Characteristics  $T_J = 175 \text{ }^{\circ}\text{C}$

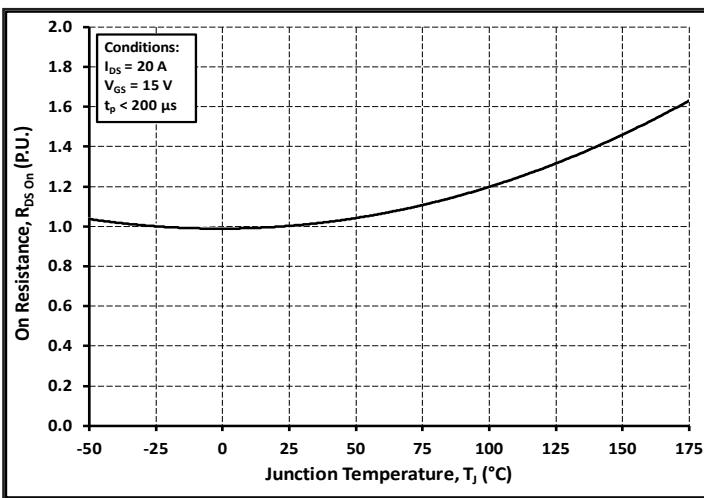


Figure 4. Normalized On-Resistance vs. Temperature

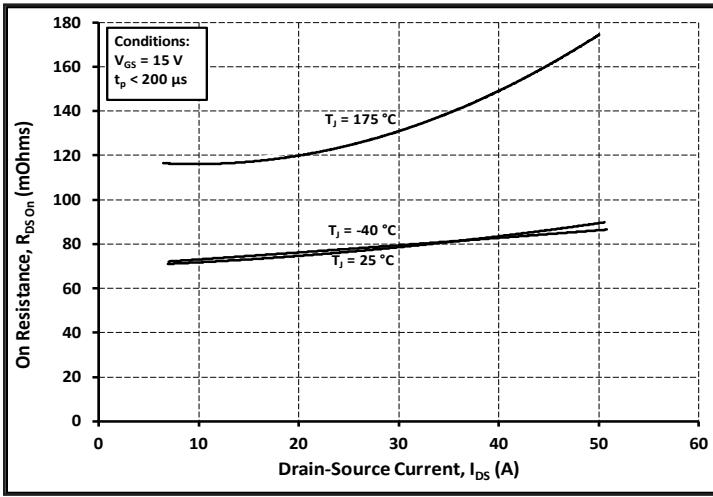


Figure 5. On-Resistance vs. Drain Current  
For Various Temperatures

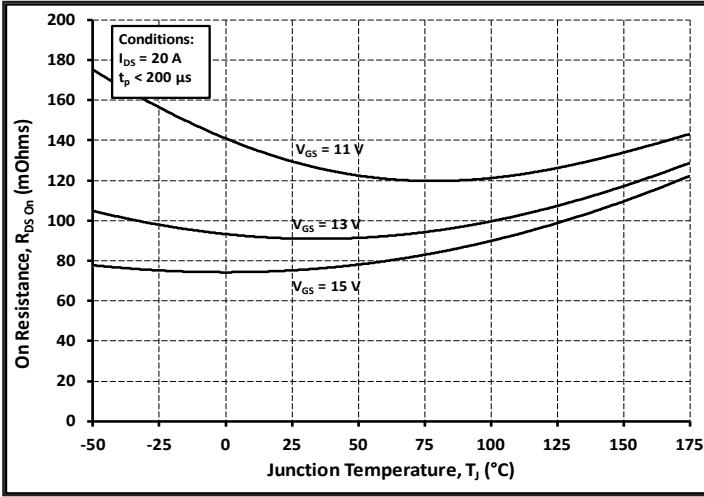


Figure 6. On-Resistance vs. Temperature  
For Various Gate Voltage

### Typical Performance

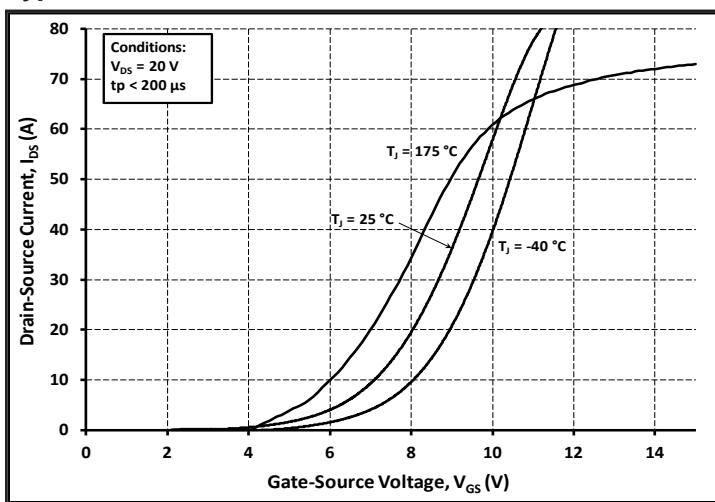


Figure 7. Transfer Characteristic for Various Junction Temperatures

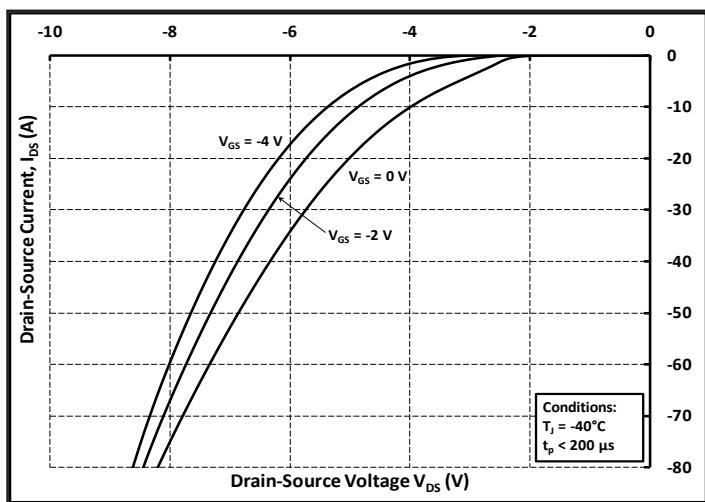


Figure 8. Body Diode Characteristic at  $-40^\circ\text{C}$

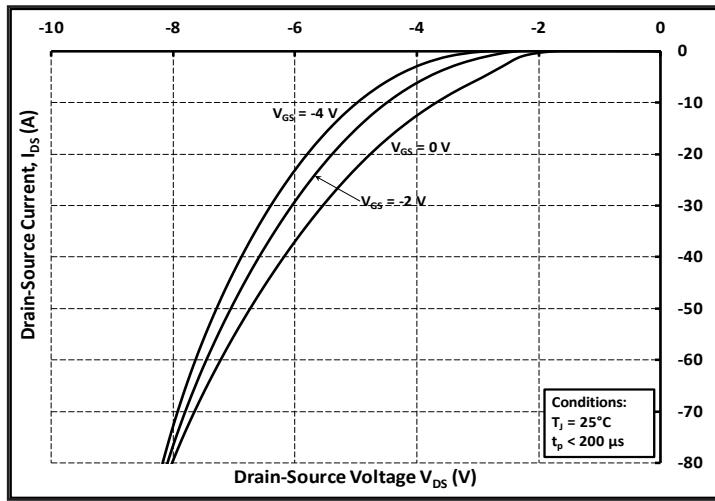


Figure 9. Body Diode Characteristic at  $25^\circ\text{C}$

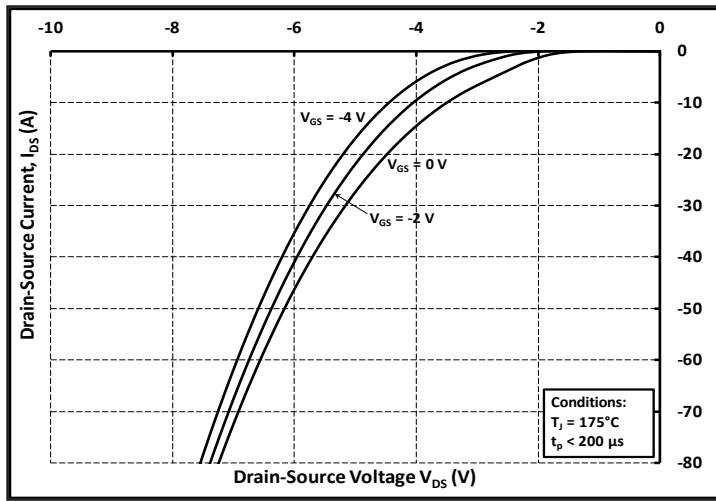


Figure 10. Body Diode Characteristic at  $175^\circ\text{C}$

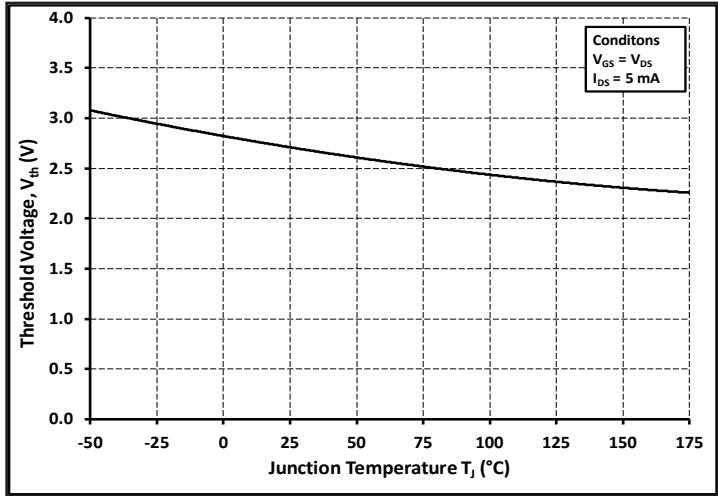


Figure 11. Threshold Voltage vs. Temperature

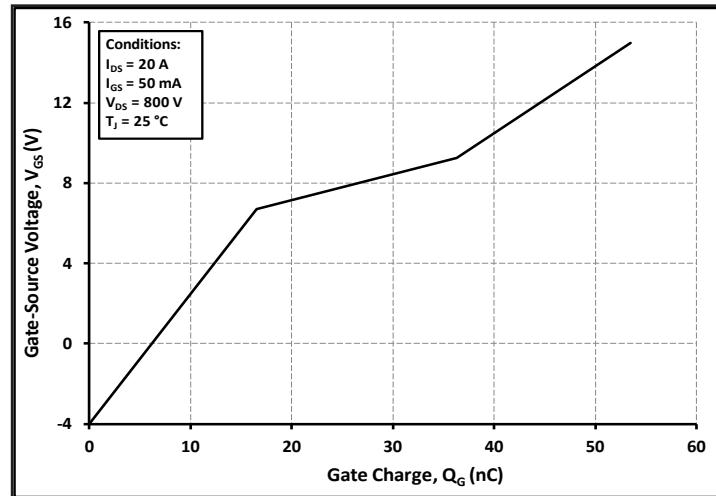


Figure 12. Gate Charge Characteristics

### Typical Performance

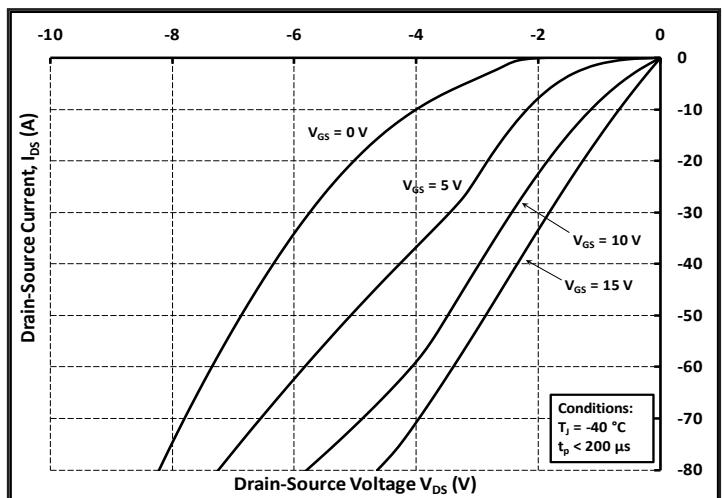


Figure 13. 3rd Quadrant Characteristic at  $-40\text{ }^\circ\text{C}$

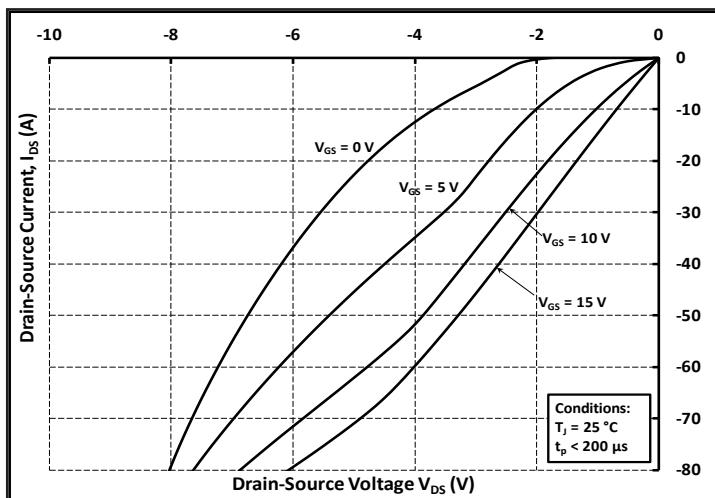


Figure 14. 3rd Quadrant Characteristic at  $25\text{ }^\circ\text{C}$

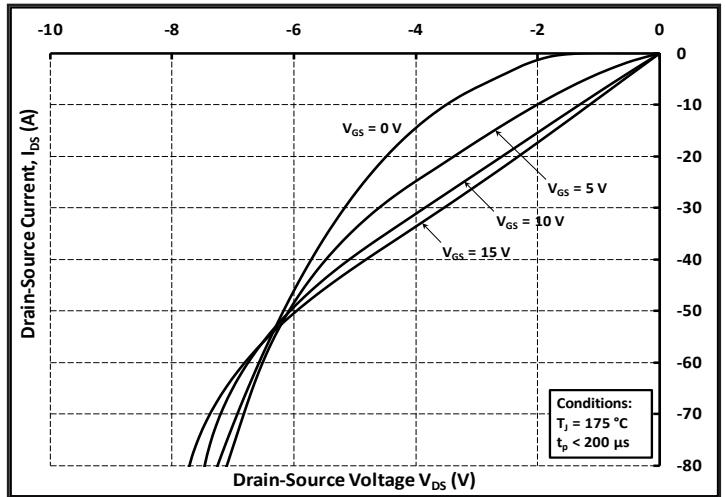


Figure 15. 3rd Quadrant Characteristic at  $175\text{ }^\circ\text{C}$

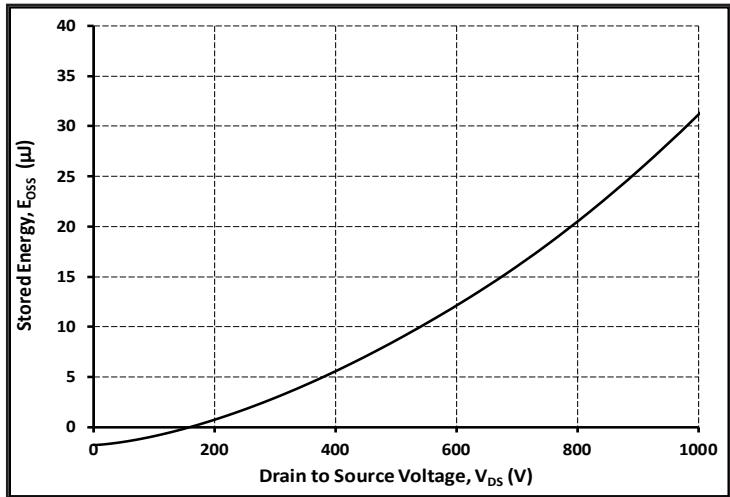


Figure 16. Output Capacitor Stored Energy

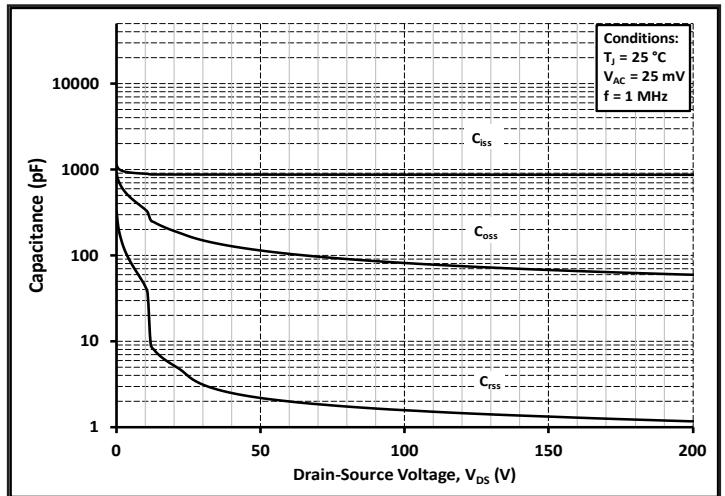


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

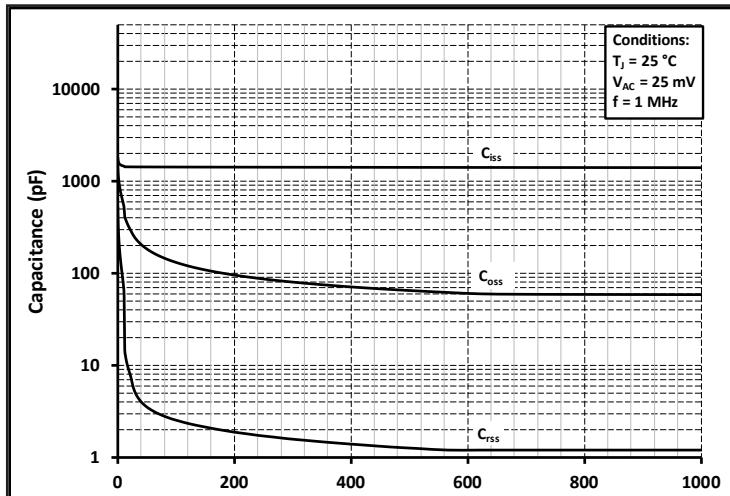


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)

### Typical Performance

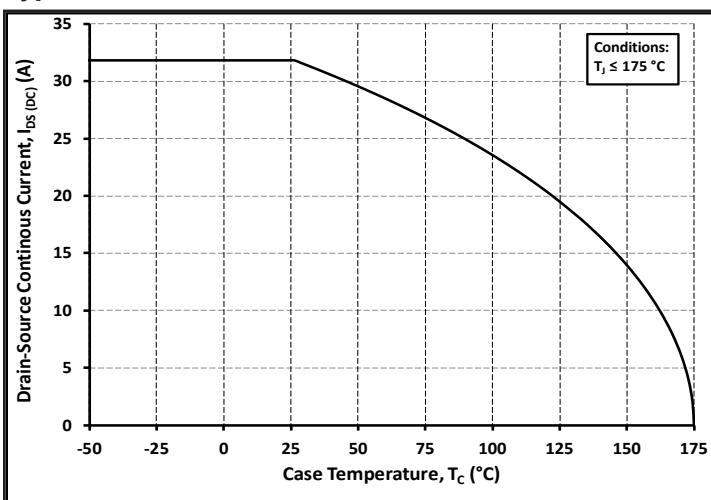


Figure 19. Continuous Drain Current Derating vs.  
Case Temperature

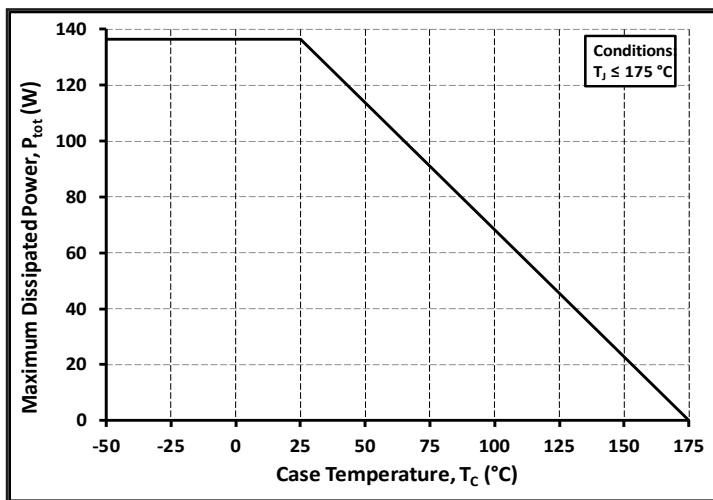


Figure 20. Maximum Power Dissipation Derating vs.  
Case Temperature

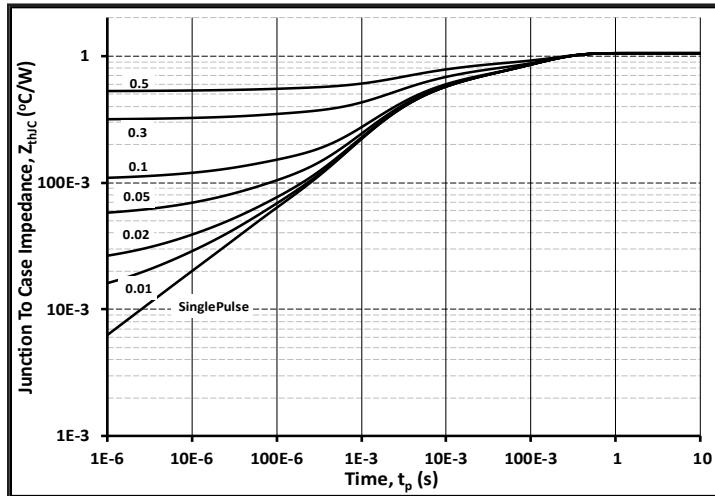


Figure 21. Transient Thermal Impedance  
(Junction - Case)

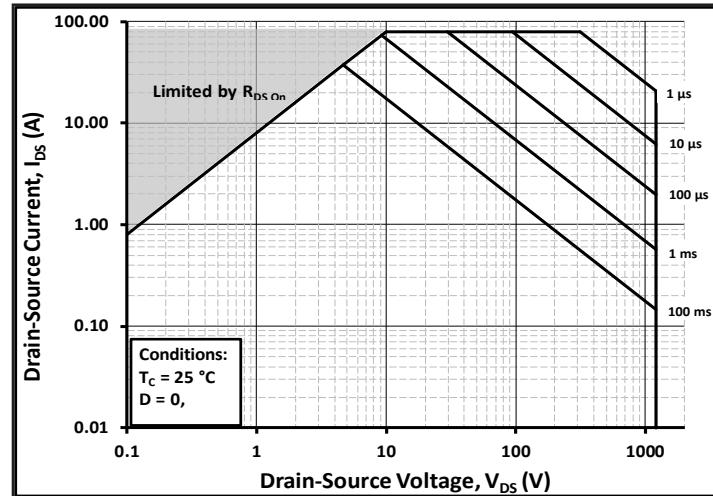


Figure 22. Safe Operating Area

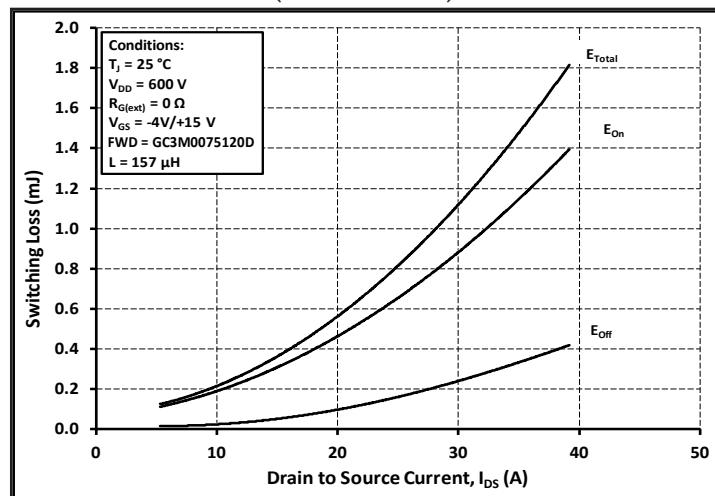


Figure 23. Clamped Inductive Switching Energy vs.  
Drain Current ( $V_{DD} = 600V$ )

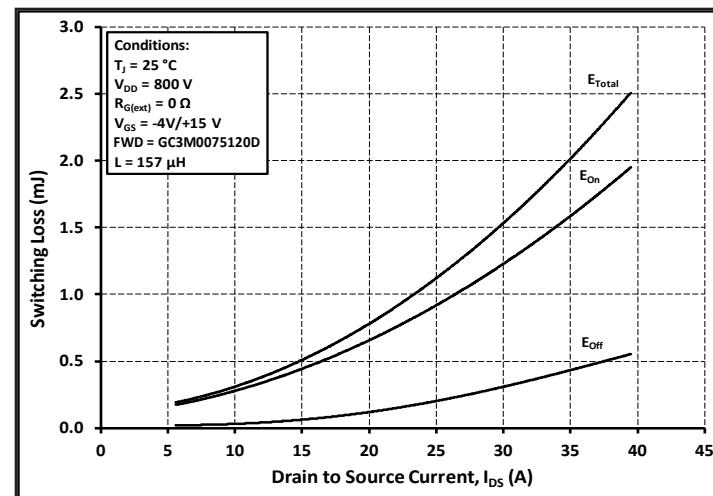


Figure 24. Clamped Inductive Switching Energy vs.  
Drain Current ( $V_{DD} = 800V$ )

### Typical Performance

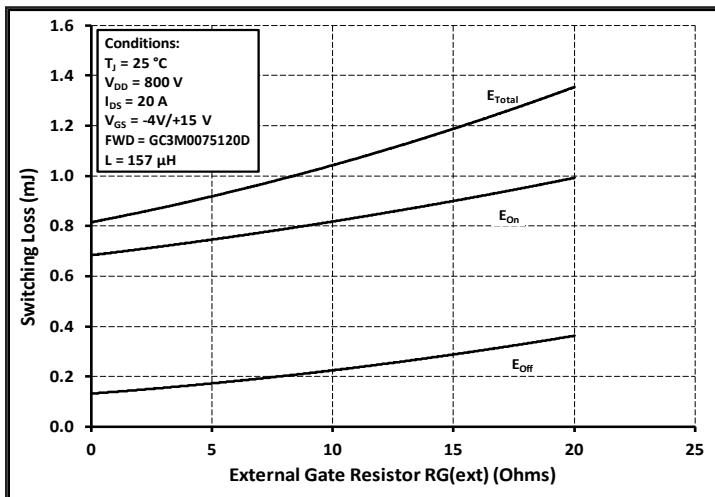


Figure 25. Clamped Inductive Switching Energy vs.  $R_{G(\text{ext})}$

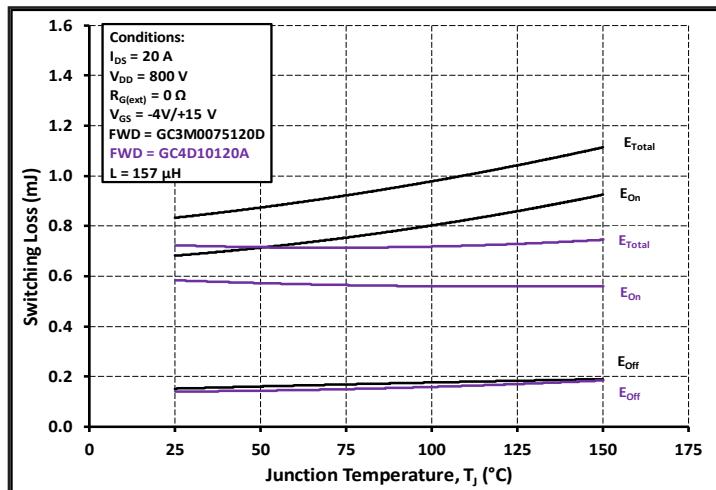


Figure 26. Clamped Inductive Switching Energy vs. Temperature

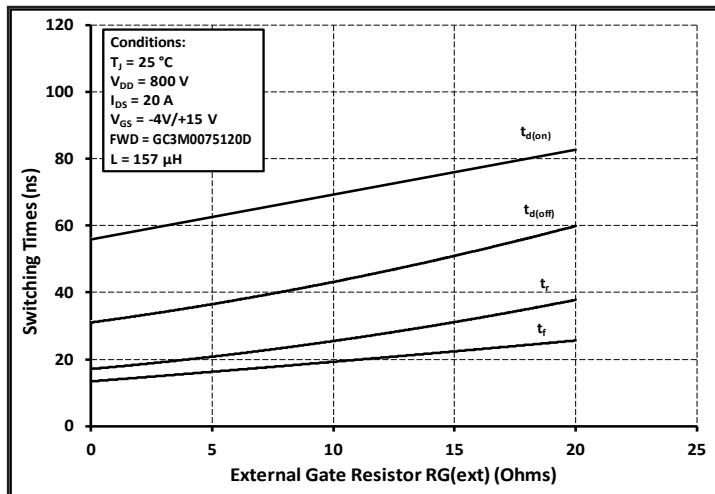


Figure 27. Switching Times vs.  $R_{G(\text{ext})}$

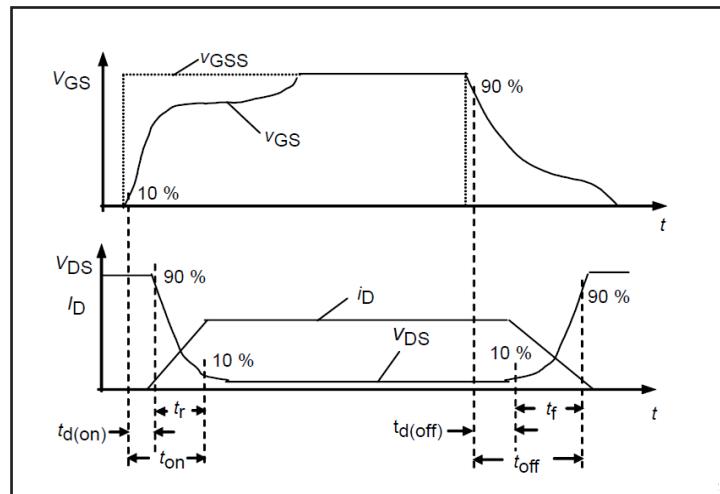


Figure 28. Switching Times Definition

## Test Circuit Schematic

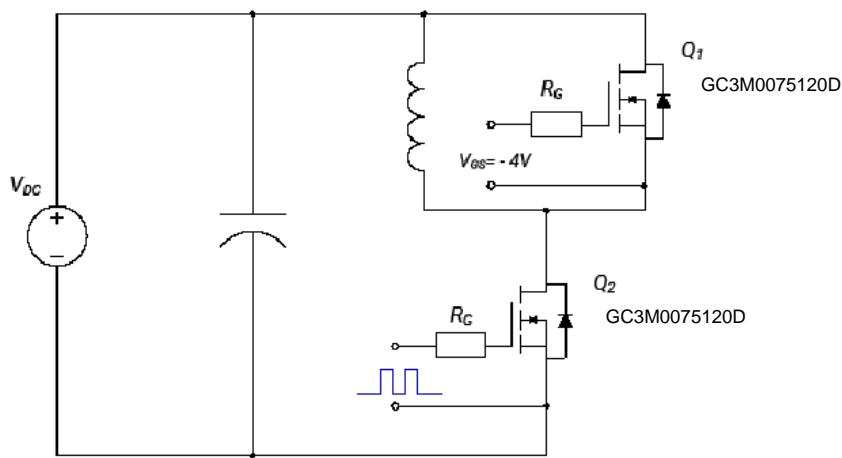
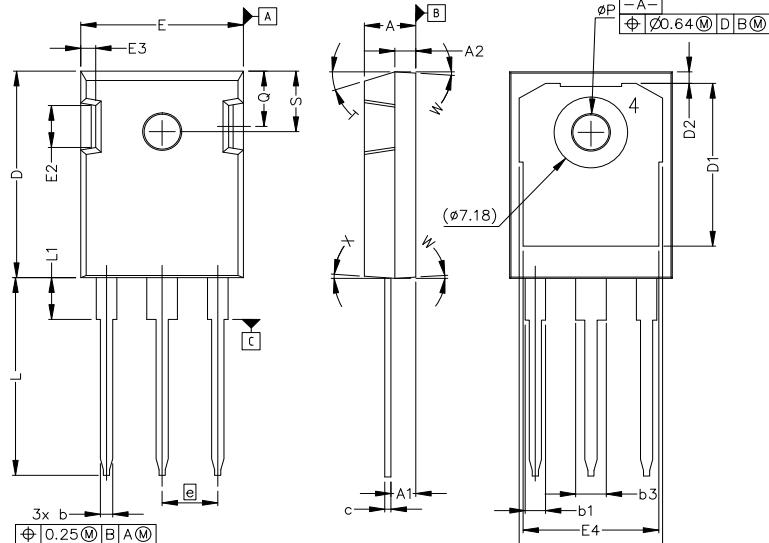


Figure 29. Clamped Inductive Switching Waveform Test Circuit

Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

## Package Dimensions

Package TO-247-3

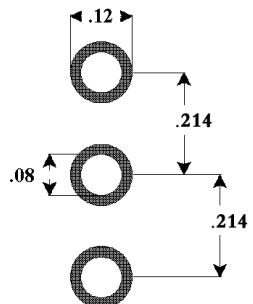


### Pinout Information:

- Pin 1 = Gate
- Pin 2, 4 = Drain
- Pin 3 = Source

SYM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.83	5.21	.190	.205
A1	2.29	2.54	.090	.100
A2	1.91	2.16	.075	.085
b	1.07	1.33	.042	.052
b1	1.91	2.41	.075	.095
b3	2.87	3.38	.113	.133
c	0.55	0.68	.022	.027
D	20.80	21.10	.819	.831
D1	16.25	17.65	.640	.695
D2	0.95	1.25	.037	.049
E	15.75	16.13	.620	.635
E1	13.10	14.15	.516	.557
E2	3.68	5.10	.145	.201
E3	1.00	1.90	.039	.075
E4	12.38	13.43	.487	.529
e	5.44 BSC		.214 BSC	
N	3		3	
L	19.81	20.32	.780	.800
L1	4.10	4.40	.161	.173
øP	3.51	3.65	.138	.144
Q	5.49	6.00	.216	.236
S	6.04	6.30	.238	.248
T	17.5° REF.			
W	3.5° REF.			
X	4° REF.			

## Recommended Solder Pad Layout



TO-247-3